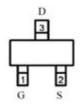
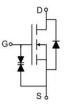


Main Product Characteristics:

V _{DSS}	60V
R _{DS} (on)	2.3Ω (Max)
I _D	0.3A







SOT-23

Pin Assignments

Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

Absolute Max Rating:

Symbol	Parameter	Max.	Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V①	0.3		
I _{DM}	Pulsed Drain Current ②	1.2	A	
P _D @T _C = 25°C	Power Dissipation ③	0.35	W	
V _{DS}	Drain-Source Voltage	60	V	
V _{GS}	Gate-to-Source Voltage	± 20	V	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 150	°C	

Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R _{θJA}	Thermal Resistance,Junction-to-Ambient ④	_	357	°C/W





Electrical Characteristics @T_A=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source breakdown voltage	60	_	_	V	V _{GS} = 0V, I _D = 250μA	
D	Static Drain-to-Source	_	2.1	2.87	Ω	V _{GS} =4.5V,I _D = 0.2A	
R _{DS(on)}	on-resistance	_	1.8	2.3	Ω	V _{GS} =10V, I _D =0.3A	
V _{GS(th)}	Gate threshold voltage	1	_	2.5	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
I _{DSS}	Drain-to-Source leakage current	_	_	1	μA	V _{DS} =60V,V _{GS} =0V	
I _{GSS}	Gate-to-Source forward leakage	_	_	±10	μA	V _{GS} =±20V,V _{DS} =0V	
Qg	Total gate charge	_	1.9	_	nC	V _{DS} =10V,I _D =0.3A, V _{GS} =4.5V	
Q _{gs}	Gate-to-Source charge	_	0.3	_			
Q_{gd}	Gate-to-Drain("Miller") charge	_	0.7	_			
t _{d(on)}	Turn-on delay time	_	2	_			
tr	Rise time	_	16	_	no	V_{DD} =10V, V_{GS} =10V, I_{D} =0.2A R_{GEN} =10 Ω	
t _{d(off)}	Turn-Off delay time	_	8	_	ns		
t _f	Fall time	_	21	_			
Ciss	Input capacitance	_	30	_	pF	\/ 05\/\/ 0\/	
Coss	Output capacitance	_	12	_		V _{DS} =25V,V _{GS} =0V, f=1.0MHz	
C _{rss}	Reverse transfer capacitance	_	5	_		I – I.UIVII IZ	

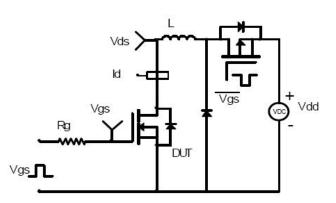
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current	_	_	0.3	А	MOSFET symbol
Is	(Body Diode) ①					showing the
Ism	Pulsed Source Current	_	_	1.2	Α	integral reverse
	(Body Diode) ①					p-n junction diode.
V _{SD}	Diode Forward Voltage	_	_	1.2	V	I _S =0.3A, V _{GS} =0V,T _J = 25°C

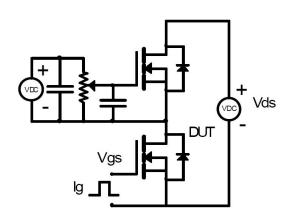


Test Circuits and Waveforms:

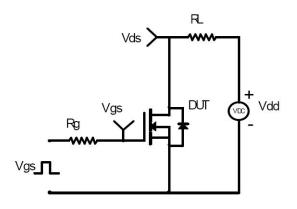
EAS Test Circuit:



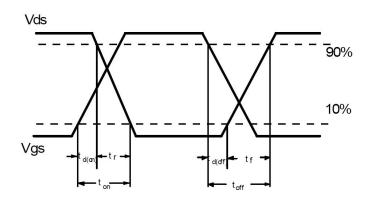
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



Version : Preliminary

Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ④ The value of R_{θJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25 $\,^{\circ}$ C



Mechanical Data:

Symbol	Dimension I	n Millimeters	Dimension In Inches		
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.95	STYP	0.037TYP		
e1	1.800	2.000	0.071	0.079	
Ĺ	0.55	REF	0.022REF		
L1	0.300	0.500	0.012	0.020	
θ	O ⁰	8 ⁰	00	8 ⁰	





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